## INFORMATION DISCLOSURE CITATION Applicant(s) Bahadur et al (Use several sheets if necessary) Filing Date Group Art Unit U.S. PATENT DOCUMENTS EXAMINER FILING DATE DATE NAME CLASS SUBCLASS REF DOCUMENT NUMBER INITIAL IF APPROPRIATE 10/14/86 Crivello et al 428 452 4,617,238 02/28/89 525 106 4,808,664 Saam 528 15 12/14/93 Brown et al 5,270,423 31 5,594,042 01/14/97 Glover et al 522 447 5,629,095 05/13/97 Bujanowski et al 428 09/09/97 525 106 5,665,823 Saxena et al 10/26/99 Kerr, III et al 522 25 5,973,020 09/569,283 05/12/00 Bahadur et al. Sincl FOREIGN PATENT DOCUMENTS Translation DATE CLASS SUBCLASS REF DOCUMENT NUMBER COUNTRY YES 07/09/92 **PCT** C08F 2/54 WO 92/11295 04/18/91 **PCT** C08F 8/00 WO 91/04992 EP 462389 12/27/91 European (Abstract & Equiv) C08G 077/14 European (Abstract & Equiv) SMY EP 562922 09/29/93 C08G 077/04 OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Polymer Bulletin, by J.P. Kennedy, Sandor Nemes & Tibor Pernecker, published 1991, V. 25, pp. 633-640 Radtech North America Proceedings, by N.A. Merrill, I.J. Gardner & V.L. Hughes, published 1992, V. 1, pp 77-85

EXAMINER STIP MOLLIN DATE CONSIDERED 12/9

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

## INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Applicant(s) Bahadur et al. Filing Date Group Art Unit

U.S. PATENT DOCUMENTS											
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE  IF APPROPRIATE				
	·						-				
				FOREIGN PATENT DOCUMENTS							
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation YES NO				
_											
		Deleman Bellekin ber Tir		<del>-</del>		te, Pertinent Pag	ges, Etc.)				
8ml	_	r olymer Bulletill, by 1.2	. Liao and J. F. i	Kennedy, published 1981, V. 6, pp. 13	5-141						
Sm.	L	Journal of Polymer Scien	Journal of Polymer Science, Part A, Polymer Chemistry, by J.P. Kennedy & B. Ivan, published 1990, V. 28, pg 89								
EXAMINE	R <	For Mr	lul	DATE CONSIDERED	19/02						
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											

Form PTO-A820 (also form PTO-1449)

P09A/REV04

Patent and Trademark Office \* U.S. DEPARTMENT OF COMMERCE

## INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

DC:	
Applicant(s) Bahadur et al	
Filing Date	Group Art Unit

U.S. PATENT DOCUMENTS											
EXAMINER INITIAL	REF		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE  IF APPROPRIATE			
							<u> </u>	II ALLIN	PRIATE		
		<u> </u>		<del></del>			<del> </del>	-			
				<u> </u>				<u> </u>			
		l l									
					}						
					;						
			<del> </del>		:						
				<u></u>	FOREIGN PATENT DOCUMENTS		J	<del></del>			
	REF		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation			
								YES	NO		
				<u> </u>			ļ				
				<del></del>	OTHER DOCUMENTS (Including A	uthor, Title, Do	ate, Pertinent Pa	ges, Etc.)			
SMC			Polymer Coatings for Optical Fibers, CHEMTECH, by Blyler & Aloisio, published November 1987, pp. 680-684								
Angewandte Chem. Int. Ed. Engl. 30, by Hitchcock et. al., published 1991,pp. 438-440											
EXAMINER SOM MYCLU DATE CONSIDERED SOM OG / OG											
EXAMINER: Initial if creation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											
iot considered. Include copy of this form with next communication to applicant.											